

## SILICON TRANSISTOR ARRAY

# $\mu$ PA1454

## NPN SILICON POWER TRANSISTOR ARRAY LOW SPEED SWITCHING USE INDUSTRIAL USE

#### **DESCRIPTION**

The  $\mu$ PA1454 is NPN silicon epitaxial Power Transistor Array that built in 4 circuits designed for driving solenoid, relay, lamp and so on.

#### **FEATURES**

- · Easy mount by 0.1 inch of terminal interval.
- High hre. Low Vce(sat).
   hre = 800 to 3200 (at Ic = 1 A)
   Vce(sat) = 1.0 V MAX. (at Ic = 3 A)

#### ORDERING INFORMATION

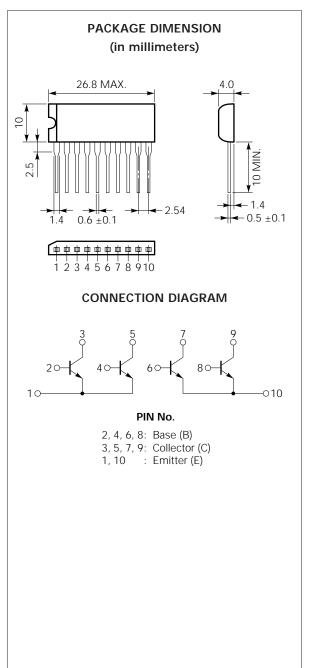
Part Number	Package	Quality Grade		
μPA1454H	10 Pin SIP	Standard		

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

#### ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C)

Collector to Base Voltage	Vсво	100	V
Collector to Emitter Voltage	$V_{\text{CEO}}$	100	V
Emitter to Base Voltage	VEBO	7	V
Collector Current (DC)	Ic(DC)	5	A/unit
Collector Current (pulse)	Ic(pulse)*	10	A/unit
Base Current (DC)	IB(DC)	1.0	A/unit
Total Power Dissipation	P <sub>T1</sub> **	3.5	W
Total Power Dissipation	P <sub>T2</sub> ***	28	W
Junction Temperature	Tj	150	.C
Storage Temperature	Tstg -55	to +150	) °C

- \* PW  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  10 %
- \*\* 4 Circuits, Ta = 25 °C
- \*\*\* 4 Circuits, Tc = 25 °C



The information in this document is subject to change without notice.

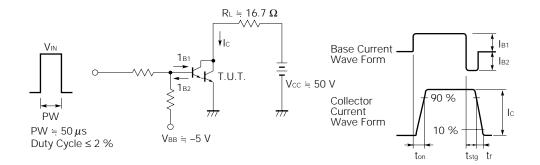


## ELECTRICAL CHARACTERISTICS (Ta = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Collector Leakage Current	Ісво			10	μΑ	Vcb = 100 V, IE = 0	
Emitter Leakage Current	Іево			10	μΑ	V <sub>EB</sub> = 7 V, I <sub>C</sub> = 0	
DC Current Gain	h <sub>FE1</sub> *	800	1300	3200	_	Vce = 5 V, Ic = 1 A	
DC Current Gain	h <sub>FE2</sub> *	500	1000		_	Vce = 5 V, Ic = 3 A	
Collector Saturation Voltage	VCE(sat) *			1.0	V	Ic = 3 A, I <sub>B</sub> = 30 mA	
Base Saturation Voltage	V <sub>BE(sat)</sub> *			1.2	V	Ic = 3 A, I <sub>B</sub> = 30 mA	
Turn On Time	ton		1		μs	Ic = 3 A	
Storage Time	tstg		3		μs	$I_{B1} = -I_{B2} = 30 \text{ mA}$ $- V_{CC} \doteqdot 50 \text{ V, RL} \doteqdot 16.7 \Omega$ See test circuit	
Fall Time	<b>t</b> f		1.5		μs		

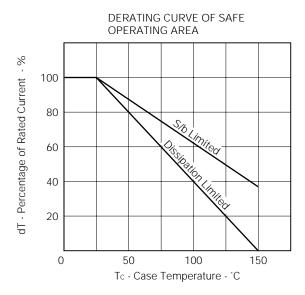
<sup>\*</sup> PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2 % / pulsed

### SWITCHING TIME TEST CIRCUIT

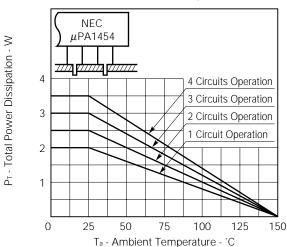




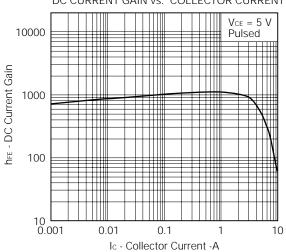
#### TYPICAL CHARACTERISTICS (Ta = 25 °C)

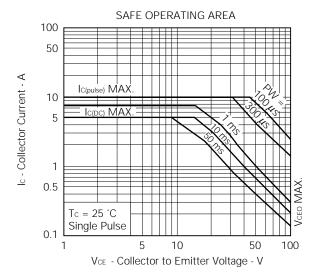




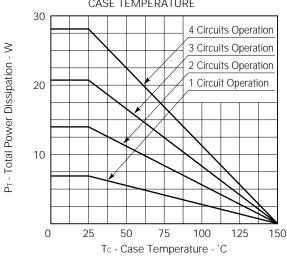


DC CURRENT GAIN vs. COLLECTOR CURRENT

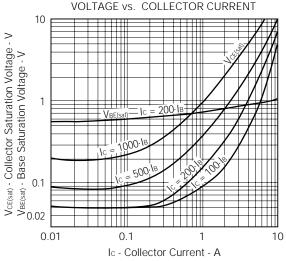


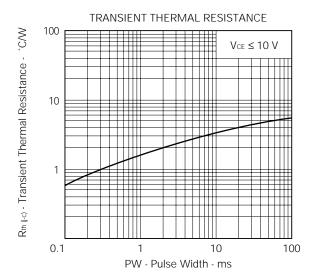


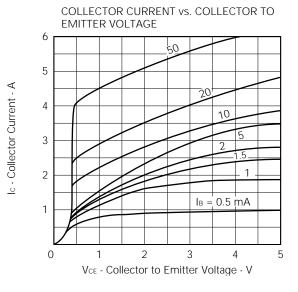
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



BASE AND COLLECTOR SATURATION VOLTAGE VS. COLLECTOR CURRENT









## REFERENCE

Document Name	Document No.
NEC semiconductor device reliability/quality control system.	TEI-1202
Quality grade on NEC semiconductor devices.	IEI-1209
Semiconductor device mounting technology manual.	IEI-1207
Semiconductor device package manual.	IEI-1213
Guide to quality assurance for semiconductor devices.	MEI-1202
Semiconductor selection guide.	MF-1134

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Special: Automotive and Transportation equipment, Traffic control systems, Antidisaster systems, Anticrime systems, etc.

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